





Gorbunov Maksim S. Exam Schedule

Tue, 16 Apr	09:20 — 11:50	TEST	Design of Radiation-Hard Fault-Tolerant Digital CMOS VLSI (in English)	 S14-403
			D-303	
Fri, 19 Apr	14:30 — 16:05	TEST	Design of Radiation-Hard Fault-Tolerant Digital CMOS VLSI (in English)	 S14-404
			D-311	